

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10720074	LIN ET AL.
	<b>Examiner</b> FLEURANTIN, JEAN B	<b>Art Unit</b> 2162

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	1-10, 100-104.1 & 200-206	8/30/2007	JBF
709	225	8/30/2007	JBF
713	152, 164 & 166	8/30/2007	JBF
726	1, 2 & 12	8/30/2007	JBF

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	8/30/2007	JBF
707/ccls & Inventors Search & all related applications have been reviewed.	8/30/2007	JBF
NPL - IEEE	8/30/2007	JBF

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>